New Route from Si-**O to Si**-**C Bonds: Alkylalkoxysilanes from Alkoxysilanes and Metal Hydrides**

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The typical pathway from silicon-oxygen to silicon-carbon bonds involves nucleophilic attack of an organometallic reagent on the silicon center. A new transformation from siliconoxygen to silicon-carbon bonds is reported that proceeds without nucleophilic attack of a carbanion. The reaction of $Si(OMe)_4$ with NaH yields MeSi(OMe)₃ at temperatures above 300 °C. Mechanistic studies indicate that an intact methyl group is transferred from a methoxy group to the silicon center in the Si-C bond-forming step.

Introduction

Silicone polymers of the general structure (RR′SiO)*ⁿ* are widely used in numerous applications.¹ The ultimate source of silicon atoms for silicone materials is silicon dioxide. Considering that about 60% of Earth's crust is composed of silica and silicates, the relatively high cost of silicones is not a function of raw material cost, but the result of enormous energy consumption during the manufacturing process. The major contributor to the high cost of silicones is an energy-intensive, carbothermal reduction step from $SiO₂$ to elemental silicon. An alternative route to silicones is depicted in eq 1, where the reduction and reoxidation of silicon is avoided.

$$
\text{SiO}_2 \rightarrow \text{Si(OR)}_4 \rightarrow \text{R}_2\text{Si(OR)}_2 \rightarrow (\text{R}_2\text{SiO})_n \tag{1}
$$

Significant advances have been made in the activation and depolymerization of $SiO₂$ to produce monomeric Si compounds.2 The direct conversion of silicon-oxygen to silicon-carbon bonds is currently based on stoichiometric nucleophilic substitution reactions³ at the silicon center (eq 2) involving costly organometallic reagents, almost exclusively of the alkyllithium and Grignard type.2b,c,f,4 In this context we decided to explore new routes from Si-O to Si-C bonds.

⁽¹⁾ Rich, J.; Cella, J.; Lewis, L.; Stein, J.; Singh, N.; Rubinsztajn, S.; Wengrovius, J. *Silicon Compounds*; Wiley: New York, 1997; Vol.

 $\text{SiO}_2 \rightarrow \text{Si}(\text{OR})_2 \rightarrow \text{R}_2\text{Si}(\text{OR})_2 \rightarrow (\text{R}_2\text{SiO})$ (1) **Figure 1.** GC traces of the reactor downstream for the reaction of $Si(OMe)_4$ with NaH at 275 °C (A) and at 350 $^{\circ}$ C (B). MeSi(OMe)₃ is the dominant product at 350 $^{\circ}$ C (C).

Tetramethoxysilane was chosen as starting material since substitution of two methoxy groups by methyl groups results in $Me₂Si(OMe)₂$, a direct precursor to silicones. Additionally, $Si(OMe)_4$ is a low-boiling fluid that can easily be used in various reactor types. In an attempt to react $Si(OMe)_4$ under strongly reducing conditions, we studied the reaction of $Si(OMe)_4$ with NaH in a fixed-bed reactor.

Results and Discussion

When Si(OMe)4 was passed through a bed of NaH at temperatures above 200 °C, a new peak besides unreacted $Si(OMe)_4$ was observed in the GC trace (retention time: 2.6 min; Figure 1A). The peak represented $HSi(OMe)_3$ as confirmed by GC/MS and ²⁹Si NMR.⁵ At temperatures above 275 °C, an additional peak (retention time: 3.7 min) was found in the GC trace. The peak increased in intensity as the reactor temperature was raised and represented the only significant product at

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325 °C and above (Figure 1B). Surprisingly, this compound was identified by GC/MS and 29Si NMR to be MeSi(OMe)3. By comparison, Kuznetsov reported that no reaction occurred between $Si(OEt)_4$ and NaH in solution at temperatures up to 168 °C.⁶ Other hydrides such as LiH and N aBH₄ similarly reacted with $Si(OMe)_4$ to form MeSi(OMe)3, but were found to be less reactive and required higher reaction temperatures. The formation of $\text{MeSi}(\text{OMe})_3$ from $\text{Si}(\text{OMe})_4$ and NaH (Figure 1C) represents a new and unexpected transformation from Si-O to Si-C bonds.

The low byproduct production combined with the high symmetry of the starting material, $Si(OMe)_4$, allowed us to study the mechanism of this unusual reaction in more detail. The question, if $HSi(OMe)_3$ and MeSi-(OMe)3 were formed independently from each other or if HSi(OMe)3 was an intermediate in the formation of $MeSi(OMe)_3$, was addressed by reacting $HSi(OMe)_3$ with NaH. MeSi $(OMe)_3$ was observed as a product at temperatures as low as 200 °C, when $HSi(OMe)$ ₃ was passed through a bed of NaH. The relative amount of MeSi- $(OMe)_3$ formed increased as the reactor temperature was raised. At 325 °C, 37% of the reactor downstream mixture was composed of MeSi(OMe)₃. Additionally, the formation of $\text{Me}_2\text{Si}(\text{OMe})_2$ was observed. In the absence of NaH, $HSi(OMe)_3$ was found to be thermally stable beyond 350 °C. This result suggests that $\text{MeSi}(\text{OMe})_3$ is formed from intermediately formed $HSi(OMe)₃$. Significant redistribution of $HSi(OMe)_3$ into SiH_4 and Si - $(OMe)_4$ was observed, a reaction with precedence in the literature.⁷

Deprotonation of $HSi(OMe)_3$ by NaH to form a sodium silyl species is a conceivable first step in the formation of MeSi(OMe)₃ from intermediately formed HSi(OMe)₃. The related formation of $KSEt_3$ from KH and $HSEt_3$ was reported by Corriu et al.⁸ If in fact NaH reacted as a base with $HSi(OMe)_3$ to form $MeSi(OMe)_3$, then the reaction of $HSi(OMe)_3$ with a different, sufficiently strong base should also lead to formation of MeSi- $(OMe)₃$. Indeed, $MeSi(OMe)₃$ was generated in the reaction of HSi(OMe)3 with potassium *tert*-butoxide (K-O-*t*-Bu) at 175 °C. Again, redistribution of HSi(OMe)3 into $Si(OMe)_4$ and SiH_4 was observed. Neat $Si(OMe)_4$ did not react with K-O-*t*-Bu, confirming that only HSi- $(OMe)_3$, but not the concurrently formed $Si(OMe)_4$, reacted with base. These results are further evidence that $HSi(OMe)_3$ was an intermediate in the formation of MeSi(OMe)₃.

GC/MS analysis of the carrier gas exiting the reactor during the reaction of Si(OMe)4 and NaH at 325 °C revealed the formation of H_2 and methane. When Si- $(OMe)_4$ was reacted with LiD at 375 °C, HD and CH₃D were observed as the dominant products. The observed methane formation suggested nucleophilic attack of the hydride or deuteride at a CH₃ group of Si(OMe)₄. The generation of H_2 is further indication for the deprotonation of HSi(OMe)₃ by NaH.

An important question was whether an intact methyl group was transferred in the $Si-C$ bond-forming step. Reaction of $Si(OMe)_4$ with LiD at 400 °C yielded a

Figure 2. GC trace (A) and NMR data of the reactor downstream for the reaction of $Si(OMe)_4$ with LiD at 400 °C. The 13C NMR (B) and 1H NMR (C) spectra each show the region typical for methyl groups directly bound to silicon.

Figure 3. Proposed mechanism of the direct formation of $MeSi(OMe)_3$ from $Si(OMe)_4$ and NaH: (A) Nucleophilic attack of H^- at $Si(OMe)_4$; (B) H-abstraction to form a sodium silyl derivative; (C) Si-C bond formation by nucleophilic attack of the silyl group. Methane formation (D) and redistribution of $HSi(OMe)_3$ (E) are undesired side reactions.

mixture that contained 22% MeSi(OMe)₃ as determined by GC (Figure 2A). The 13C NMR spectrum (1H decoupled) of the reaction mixture revealed one dominant peak ($>90\%$) in the region expected for CH_3-Si (Figure 2B). A singlet at -8.9 ppm suggested that no scrambling of deuterium into C*H*³-Si had occurred. Similarly, the ¹H NMR spectrum exhibited a singlet at 0.11 ppm as the dominant peak in the Si-Me region (Figure 2C). In the ²H NMR, a small signal was detected at -0.05 ppm, only a trace amount based on intensity estimates using the 13C satellites of the solvent signal. Consistent with the 1 H and 13 C NMR data, the 29 Si NMR spectrum exhibited a singlet at -39.3 ppm as expected for CH_3 Si(OMe)3. Also, MS (chemical ionization) did not show significant enrichment of deuterium in $MeSi(OMe)_{3}$. The NMR and MS studies indicated that more than 90% of the formed MeSi(OMe)₃ did not contain deuterium and suggested transfer of an intact methyl group to the silicon center in the Si-C bond-forming step.

On the basis of the presented data we propose a mechanism for the formation of $MeSi(OMe)_3$ from Si- $(OMe)_4$ and NaH (Figure 3). Initially $HSi(OMe)_3$ is generated from $Si(OMe)_4$ by nucleophilic attack of H⁻ at the silicon center (Figure 3A). In the second step (Figure 3B), the NaH acts as a base and reacts with $HSi(OMe)_3$ to form a sodium silyl species, presumably $NaSi(OMe)₃$. The sodium silyl derivative presumably reacts by nucleophilic attack on a methoxy group of,

⁽⁶⁾ Kuznetsov, A. I. *Zh. Prikl. Khim.* **1978**, *51*, 1833.

⁽⁷⁾ Suzuki, E.; Okamoto, M.; Ono, Y. *Chem. Lett.* **1989**, 1487.

⁽⁸⁾ Corriu, R. J. P.; Guerin, C. *J. Chem. Soc., Chem. Commun.* **1980**, 168.

most likely, another $Si(OMe)_4$ to form $MeSi(OMe)_3$ (Figure 3C).9 The formation of methane by nucleophilic attack of H^- on a methyl group of $Si(OMe)_4$ (Figure 3D) and the redistribution of $HSi(OMe)_3$ into $Si(OMe)_4$ and SiH4 (Figure 3E) represent unproductive side reactions negatively affecting the yield of $MeSi(OMe)_3$. Cumulative yields of $35-40\%$ MeSi(OMe)₃ based on Si(OMe)₄ were found, when a slight excess of NaH was used assuming consumption of two $Si(OMe)_4$ per $MeSi(OMe)_3$ formed. Although pentacoordinate silicon species are likely intermediates during the various reaction steps, no signals were found in the region typical for higher coordinated silicon species in the solid state 29Si NMR spectrum of the bed after partial reaction.

Analogous silicon-carbon bond formation was observed with higher substituted alkoxysilanes such as $Si(OEt)₄$ and $Si(O-n-Pr)₄$ in the reaction with NaH to form the corresponding alkyltrialkoxysilanes. Transfer of an intact alkyl group further supports the proposed mechanism.

Conclusions

We report a new reaction pathway from $Si-O$ to $Si-C$ bonds starting from tetraalkoxysilanes and metal hydrides. Mechanistic studies indicate that the formation of $MeSi(OMe)_3$ from $Si(OMe)_4$ proceeds via formation of HSi(OMe)3. The Si-C bond-forming step involves methyl transfer from a methoxy group onto the silicon center. Surprisingly, an electrophilic alkyl fragment is transferred in the Si-C bond-forming step, in contrast to the typical nucleophilic substitution.

Experimental Section

General Considerations. All reactions were performed in a fixed-bed reactor setup installed inside of a fume hood. The reactor outlet stream was vented into the back of the hood to ensure effective ventilation of the outgasses, particularly the highly flammable SiH_4 , a product of the significant $\text{HSi}(\text{OMe})_3$ disproportion reaction. Sodium hydride (95% purity) was purchased from Aldrich and handled under an inert gas atmosphere. $Si(OMe)_4$ (99.5% purity) was purchased from Aldrich and used as is. The fractions collected at the reactor outlet were analyzed using a Hewlett-Packard 6890 gas chromatograph and frequently reanalyzed using GC/MS (JEOL model HX110 mass spectrometer) equipped with a J&W Scientific DB-5 MS column. All NMR data were obtained on GE NMR Instruments Omega nuclear magnetic resonance spectrometers operating at 500 MHz (11.75T) for 13C, 29Si, and 2 H and at 300 MHz (7.06T) for 1 H. A JEOL SX-102 mass spectrometer was used for MS gas phase analysis. Elemental analysis of the reactor bed samples was performed using a Varian Liberty II ICP-AES instrument. Digestion methods were used for sample preparation.

Typical Procedure for Reaction of Si(OMe)4 with NaH as a Function of Temperature (Example 1). Sodium hydride (0.97 g; 40 mmol) was charged into a fixed-bed flow reactor with vertical furnace and flushed with argon carrier gas at a rate of 20 mL/min. The initial reactor temperature was 200 °C. The reaction was performed using argon as carrier gas (14 mL/min). Tetramethoxysilane [Si(OMe)4] (2.13 mL/h; 14.4 mmol/h) was fed into the carrier gas stream using a motor-driven syringe. The reactor effluent downstream was collected in fractions using a water-chilled condenser and analyzed by gas chromatography. The reaction was carried out with a temperature ramp starting at 200 °C. After collecting

a fraction, typically in a range between 0.5 and 2 g, the reactor temperature was increased by 25 or 50 °C for screening purposes. Methyltrimethoxysilane [MeSi(OMe)₃] and trimethoxysilane $[HSi(OMe)_3]$ formation was confirmed by gas chromatography, GC/MS, and multinuclear NMR techniques. HSi- $(OMe)_3$ formation was first detected at 225 °C, and MeSi $(OMe)_3$ formation was first detected at 325 °C. Total amount of Si- $(OMe)_4$ reacted $(= Si(OMe)_4$ added $- Si(OMe)_4$ recovered): 2.81 g (18.5 mmol); total amount $\text{MeSi}(\text{OMe})_3$ formed: 87 mg (0.6 mmol); total amount HSi(OMe)₃ formed: 115 mg (0.9 mmol); amount of Si detected in the reactor bed after reaction: 18.2% (344 mg; 12.3 mmol).

Reaction of Si(OMe)4 with NaH at Fixed Temperature. The procedure of example 1 was followed with the following modifications: sodium hydride (1.00 g; 41.7 mmol). Reaction was carried out at a fixed temperature of 325 °C. Total amount of $Si(OMe)_4$ reacted (= $Si(OMe)_4$ added - $Si(OMe)_4$ recovered): 2.28 $g(15.0 \text{ mmol})$; total amount MeSi $(OMe)_3$ formed: $253 \text{ mg}(1.9)$ mmol); total amount HSi(OMe)₃ formed: 102 mg (0.7 mmol).

Reaction of HSi(OMe)4 with NaH. The procedure of example 1 was followed with the following modifications: sodium hydride $(1.01 \text{ g}; 42.1 \text{ mmol})$; HSi $(OMe)_3 (2.13 \text{ mL}; 16.7$ mmol/h) was added instead of $Si(OMe)_4$. Me $Si(OMe)_3$ formation was already detected at the initial temperature of 200 °C (0.5% of the reactor downstream). The concentration of $MeSi(OMe)_{3}$ in the reactor downstream steadily increased with increasing temperature, and at 325 °C, 37.3% of the reactor downstream was found to be $MeSi(OMe)₃$.

Reaction of Si(OMe)4 with LiD. The procedure of example 1 was followed with the following modification: lithium deuteride (1.82 g; 228 mmol) was used instead of sodium hydride. A larger excess of LiD was used to ensure comparable reactor bed height. MeSi(OMe)₃ formation was first detected at 350 °C (0.7% of the reactor downstream) and increased with increasing temperature (3.6% MeSi(OMe)₃ at 375 °C and 21.5% $MeSi(OMe)_{3}$ at 400 °C).

Reaction of Si(OMe)4 with NaBH4. The procedure of example 1 was followed with the following modification: sodium borohydride (1.04 g; 27.5 mmol) was used instead of sodium hydride. $MeSi(OMe)_3$ formation was first detected at 375 °C (0.5% of the reactor downstream) and increased with increasing temperature (2.9% MeSi(OMe)₃ at 400 °C and 6.3% MeSi (OMe) ₃ at 425 °C).

Reaction of HSi(OMe)3 with K-O-*t***-Bu.** The procedure in example 1 was used with the following modifications: potassium-*tert-*butoxide (0.98 g; 8.7 mmol) was used instead of sodium hydride; trimethoxysilane (2.13 mL/h; 16.7 mmol/ h) was used instead of tetramethoxysilane. MeSi $(OMe)_3$ formation was first detected at 175 °C (1.8% of the reactor downstream; 3.5% at 200 °C).

Reaction of Si(OEt)4 with NaH. The procedure in example 1 was used with the following modifications: sodium hydride (95% purity, 1.00 g; 39.6 mmol); tetraethoxysilane (0.5 mL/h; 2.2 mmol/h); nitrogen (1 mL/min) was used as carrier gas. EtSi(OEt)₃ formation was first detected at 250 °C (2.1%) of the reactor downstream).

Reaction of Si(O-*n***-Pr)4 with NaH.** The procedure in example 1 was used with the following modifications: sodium hydride (95% purity, 1.00 g; 39.6 mmol); tetra-*n*-propoxysilane (1.5 mL/h; 5.2 mmol/h); argon (5 mL/min) was used as carrier gas. *n*-PrSi(O-*n*-Pr)3 formation was detected at 250 °C (0.2% of the reactor downstream) and at 300 °C (1.1%).

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Supporting Information Available: Detailed description of analytical methods and a diagram of the reactor setup. This material is available free of charge via the Internet at http://pubs.acs.org.

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⁽⁹⁾ Intramolecular rearrangement followed by redistribution is also a viable alternative for the Si-C bond-forming step as one reviewer noted.